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Outline

Introduction

MAC-E filters and the KATRIN experiment

Commissioning of the Spectrometer and Detector Section (SDS) Background Electron optics

Conclusion

(Tritium) β -decay and neutrino mass

 β -decay: ${}^{A}_{Z}X_{N} \rightarrow {}^{A}_{Z+1}X_{N-1} + e^{-} + \overline{v}_{e}$





$$\frac{dN}{dE} = K F(E,Z) p \left(E_e + m_e\right) \left(E_0 - E_e\right) \sqrt{\left(E_0 - E_e\right)^2 - m\left(\overline{v}_e\right)^2}$$

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MAC-E Filter

Magnetic Adiabatic Collimation and Electrostatic Filter:



Magnetic guiding and collimation of e⁻ > Transform E_{\perp} to E_{\parallel}

Electrostatic field for energy analysis

- Sharp transmission depending on:
 - Emission angle
 - > Radius in at B_{\min}

Integrated energy resolution:

 $\Delta E = E \ \frac{B_{\min}}{E}$ $B_{\rm max}$

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Previous MAC-E filter experiments: Troisk & Mainz

Troisk experiment:



Re-analysis 2011:

$$\begin{split} m^2(v_e) &= (-0.67 \pm 1.89 \pm 1.68) \; eV^2 \\ m(v_e) &< 2.05 \; eV \end{split}$$

V.N. Aseev et al., Phys. Rev. D 84 (2011) 112003

Mainz experiment:



Final result 2004:

$$m^{2}(v_{e}) = (-0.6 \pm 2.2 \pm 2.1) eV^{2}$$

 $m(v_{e}) < 2.3 eV$

C. Kraus et al., Eur. Phys. J. C 40 (2005) 447



The **KA**rlsruhe **TRI**tium **N**eutrino experiment: Next generation direct neutrino mass experiment at KIT International collaboration: ~150 members 15 Institutions in 5 countries: D, US, ES, CZ, RUS

Member Institutions:



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KATRIN sensitivity:

- 3 full years of beam time:
- systematic and statistical error about equal:
 - $\sigma_{stat} = 0.018 \text{ eV}^2$
 - $\sigma_{syst} < 0.017 \text{ eV}^2$
- Sensitivity:
 - m(v) = 200 meV (90 % C.L.)
 - $= 350 \text{ meV} (5 \sigma)$

KATRIN beyond m(v):

- sterile neutrinos:
 - light (eV-range)
 - reactor anomaly
 - heavy (keV-range)
 warm dark matter
 - warm dark matter
- Technological advances:
 - Vacuum technology
 - Field calculation & Particle tracking simulation

etc.

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Windowless gaseous tritium source (WGTS)

- 10 m long, \otimes 9 cm tube
- Free flowing T₂ gas
- 1.7 x 10¹¹ Bq
- Stable on 10⁻³ level on
 - Inlet pressure
 - Temperature
 - Magnetic field
- Largest source of systematics
- Delivery to KIT in August 2015





Differential pumping section (DPS)

- 5 superconducting solenoids @ 5.6 T
- Active pumping with 4 TMPs
- Chicane setup
- Tritium retention by 10⁵
- Magnets set-up at KIT
- Magnet tests and beam line assembly currently ongoing







Cryogenic pumping section (CPS)

- 7 magnets @ 5.6 T
- Chicane setup
- Cryo-pumping of residual gas
- Argon frost on surface @ 3-4.5 K
- Tritium retention > 10^7
- Manufacturing in final steps
- Delivery to KIT in May 2015





Spectrometer and detector section

- Tandem spectrometer setup Pre-Spectrometer
 - Pre-filter $10^{11} \text{ e}/\text{s} \Rightarrow 10^{3} \text{ e}/\text{s}$
 - Used for R&D for Main Spec
 Main Spectrometer
 - Main energy analysis
 - $\Delta E = 0.93 \text{ eV}$

Focal plane detector (FPD)

- 148 Pixel Si-PIN diode
- $\Delta E \sim 1 \text{ keV}$





Subsystems:

Main spectrometer Focal plane detector Angular selective e⁻-source

Tests:

Hardware, Software, Slow Control Background Transmission Properties



Vacuum system:

- p < 1e-9 mbar w/o baking
- 3 IN₂ cooled baffles

High voltage system:

- running w/o major problems
 Inner electrode:
- Some electric shorts between inner and outer wire layer
- most measurements in single layer mode Magnet system:
- Pinch magnet only @ 5 T
- New Pinch just arrived at KIT E-Gun:
- runs nicely after some improveme
 Focal plane detector:
- w/o muon veto
- two minor repairs necessary



Software and slow control:

- New systems commissioned
- w/o major failures





rate

Background: Stored particles Sources:

- Radioactive decays in volume •
- Secondary processes •
- ^{219,220}Rn emanating from NEG pumps

Identification:

- Elevated pressure (~10⁻⁸ mbar) •
- High multiplicity events •

Countermeasure:

untermeasure: IN_2 cooled baffles in front of NE(pumps

Results:

Rn BG level negligible •







Background: secondary e⁻ from vessel wall/inner electrode Sources:

- Cosmic rays
- Radioactive decays on surface Identification:
- Radial dependence of BG rate
- Specific test measurements

Countermeasure:

- magnetic shielding
- electric shielding with double layer inner electrode

Results:

 Shielding very effective, but remaining BG





Total Background:

- ~400 mcps
 - design goal: 10 mcps
- volume dependent (flux tube)
- radially dependent part:
 - pressure dependent
 - IE fine tuning

But:

- Spectrometer not baked
 - Iower pressure
 - different surface conditions









Electron Optics

Angular selective e-source:

- quasi mono-energetic photo-e⁻
 created with UV-light on Au surface
- fast non-adiabatic acceleration of ein non-parallel \vec{E} and \vec{B} fields
- 4 axis movement:
 - 2 axis to cover flux tube
 - 2 axis to change pitch angle









Electron Optics

Alignment:

• Whole wafer can be covered





Electron Optics

Alignment:

- Whole wafer can be covered Low voltage characterization:
- Energy distribution of emitted e⁻
 - 0.05 < σ < 0.25 eV
 - depends on UV wavelength







Electron Optics

Alignment:

- Whole wafer can be covered Low voltage characterization:
- Energy distribution of emitted e⁻
 - $0.05 < \sigma < 0.25 \text{ eV}$
 - depends on UV wavelength

High voltage characterization:

- Angular selectivity shown
- Width: $\Delta E \approx 1.2 \text{ eV} \approx E \frac{B_{\min}}{B_{\min}}$ $E = 18.6 \text{ keV}; B_{\min} = 0.38 \text{ mT}; B_{\max} = 5 \text{ T}$





Electron Optics

Alignment:

- Whole wafer can be covered Low voltage characterization:
- Energy distribution of emitted e⁻
 - $0.05 < \sigma < 0.25 \text{ eV}$
 - depends on UV wavelength

High voltage characterization:

- Angular selectivity shown
- Width: $\Delta E \approx 1.2 \text{ eV} \approx E \frac{B_{\min}}{B_{\max}}$
- Small changes over the wafer
- Symmetric in pitch angle





Conclusions



- Source and transport section in the last manufacturing steps
- All parts delivered to KIT in Summer 2015
- 2nd Commissioning phase about to finish
- 3rd Commissioning phase in Spring 2016
- Physics runs start in Summer 2016

2nd Commissioning phase

- Test measurements on the spectrometer and detector section
- Hard- and software components operational w/o major problems
- Background further reduced, but still too high
- Electron optics look very promising
- Caution: Very preliminary results! (Some data sets < 2 weeks old) Stay tuned for more SDS-II results!



